

PCB / ICT 50

BeCu

BeCu

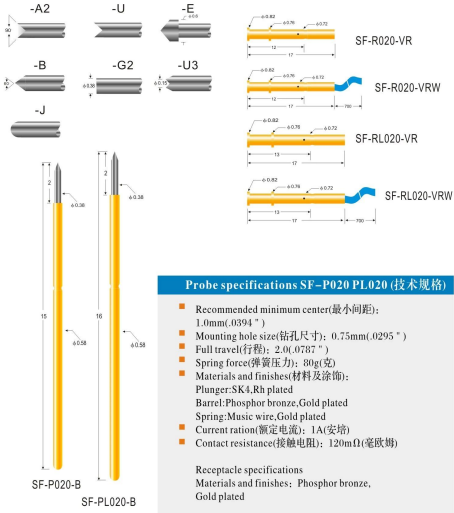


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SF-P020

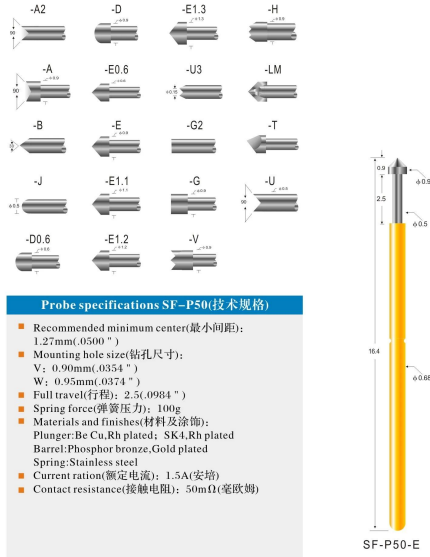


Probe specifications SF-P020 PI.020 (技术规范)

- Recommended minimum center(最小间距): 1.0mm(.0394")
 - Mounting hole size(钻孔尺寸): 0.75mm(.0295")
 - Full travel(行程): 2.0(.0787")
 - Spring force(弹簧压力): 80g(克)
 - Materials and finishes(材料及涂饰): Plunger:SK4,Rh plated; Barrel:Phosphor bronze,Gold plated; Spring:Music wire,Gold plated
 - Current rating(额定电流): 1A(安培)
 - Contact resistance(接触电阻): 120mΩ(毫欧姆)
- Receptacle specifications
Materials and finishes: Phosphor bronze, Gold plated

Noted: Specifications subject to change without notice(注: 规格变更不另行通知)

SF-P50



Probe specifications SF-P50(技术规范)

- Recommended minimum center(最小间距): 1.27mm(.0500")
- Mounting hole size(钻孔尺寸): V: 0.90mm(.0354"); W: 0.95mm(.0374")
- Full travel(行程): 2.5(.0984")
- Spring force(弹簧压力): 100g
- Materials and finishes(材料及涂饰): Plunger:Be,Cu,Rh plated; SK4,Rh plated; Barrel:Phosphor bronze,Gold plated; Spring:Stainless steel
- Current rating(额定电流): 1.5A(安培)
- Contact resistance(接触电阻): 50mΩ(毫欧姆)

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Spring loaded pin (single) for PCB, ICT, FCT testing etc;
Pogo pin (connector) to establish connection between two printed circuit boards for charging, locating, Battery, Semiconductor & Interconnect applications;
Double ended probe for BGA and Semiconductor testing;
Universal pin without spring, coating pin, LM pin with QZ and VZ series;
High current probe, Switch probe, Capacitance needle;
Terminal & receptacle /socket;
Other related electronic components, 30# OK wire, Jig locks, POM, Iron hinge etc



Spring exhausted tester



DC power supply



Current resistance tester



Microscope



Tensile strength tester



Spring tester



